



Hearing Aid Compatibility (HAC)

RF EMISSIONS TEST REPORT

For

Binatone Electronics International Ltd.

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FCC ID: VLJ- SM320

Report Type: Original Report		Product Type: GSM Mobile Phone
Test Engineer:	Ricky Wa	ng
Report Number:	R1310306	5-HAC-M
Report Date:	2013-11-1	1
Reviewed By: Prepared By:		lead
r repareu by.	1274 Anvi	

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HEARING AID COMPATIBILITY DECLARATION OF COMPLIANCE			
FCC Rule Part(s):	CFR 47 §20.19		
HAC Test Procedure(s):	ANSI C63.19-2007		
Device Category:	Portable Transmitter Held to Ear		
Modulation Type:	GMSK		
TX Frequency Range:	824.2-848.8 MHz (Cellular Band) 1850.2-1909.8 MHz (PCS Band)		
Maximum Conducted Power:32.0 dBm (Cellular Band) 28.55 dBm (PCS Band)			
Battery Type (s) Tested:	3.7 V		
M Category = M3 (ANSI C63.19-2007)			

BACL Corp. declares under its sole responsibility that this wireless portable device has been tested for Hearing Aid Compatibility in accordance with the measurement procedures specified in ANSI C63.19-2007.

All measurements reported herein were performed under my supervision and believed to be accurate to the best of my knowledge. I further attest for the completeness of these measurements and vouch for the qualifications any and all personnel performing such measurements.

The results and statements contained in this report pertain only to the device(s) evaluated.



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DOCUMENT REVISION HISTORY

Revision Number	Report Number	Description of Revision	Date of Revision
0 R1310306-HAC-M		Original Report	2013-11-11

1 GENERAL INFORMATION

1.1 Product Description for the EUT

This Bay Area Compliance Laboratories Corp. HAC Report is prepared on behalf of *Binatone Electronics International Ltd.*, and their product GSM Mobile Phone, FCC ID: VLJ-SM320, Model: SM320, or the EUT (Equipment Under Test,) as referred to in the rest of this report.

The test data gathered are from typical production sample, serial number: R1310306, provided by BACL Corp.

Item	Content	
Modulation	GMSK	
TX Frequency	Cellular Band: 824.2-848.8 MHz PCS Band: 1850.2-1909.8 MHz	
Dimensions (L x W x H)	127mm(L)×52mm(W)×14mm (H)	
Weight	88.5 g	
Power Source	3.7 V	
Operation Mode	Head and Body-worn	

1.2 Test Facilities and Accreditation

The test site used by BACL Corp. to collect radiated and conducted emissions measurement data is located at its facility in Sunnyvale, California, USA.

The test site at BACL Corp. has been fully described in reports submitted to the Federal Communication Commission (FCC) and Voluntary Control Council for Interference (VCCI). The details of these reports have been found to be in compliance with the requirements of Section 2.948 of the FCC Rules on February 11 and December 10, 1997, and Article 8 of the VCCI regulations on December 25, 1997. The test site also complies with the test methods and procedures set forth in CISPR 22:2008 §10.4 for measurements below 1 GHz and §10.6 for measurements above 1 GHz as well as ANSI C63.4-2003, ANSI C63.4-2009, TIA/EIA-603 & CISPR 24:2010.

The Federal Communications Commission and Voluntary Control Council for Interference have the reports on file and they are listed under FCC registration number: 90464 and VCCI Registration No.: A-0027. The test site has been approved by the FCC and VCCI for public use and is listed in the FCC Public Access Link (PAL) database.

Additionally, BACL Corp. is an American Association for laboratory Accreditation (A2LA) accredited laboratory (Lab Code 3297-02). The current scope of accreditations can be found at

 $\frac{http://www.a2la.org/scopepdf/3297-02.pdf?CFID=1132286\&CFTOKEN=e42a3240dac3f6ba-6DE17DCB-185}{1-9E57-477422F667031258\&jsessionid=8430d44f1f47cf2996124343c704b367816b}$

2 STANDARDS AND GUIDELINES

2.1 Application Standards

This report describes the methodology and results of experiments performed on wireless data terminal. The objective was to assess the electromagnetic characteristics and operational compatibility and accessibility of hearing aids used with wireless communications devices, including cordless, cellular, and personal communications service (PCS) phones, operating in the range of 800 MHz to 3 GHz.

ANSI C63.19 Clause 7 provides the requirements for acceptable interoperability of hearing aids with wireless devices. When these requirements are met, as defined by the tests described in this standard, a hearing aid operates acceptably with a WD.

Compatibility Tests involved:

The standard calls for wireless communications device to be measured for:

- 1) RF Electric-field emissions
- 2) RF Magnetic-field emissions
- 3) T-coil mode, magnetic-signal strength in the audio band.
- 4) T-coil mode, magnetic-signal frequency response through the audio band.
- 5) T-coil mode, magnetic-signal and noise articulation index

The hearing aid must be measured for:

- 1) RF immunity in microphone mode
- 2) RF immunity in T-coil mode

The categories begin with a minimal level of performance, which is described as "usable." From this minimum level, steps are provided for both the WD and hearing aid. Improvement in either device moves the performance first to the "regular use" and then to the "excellent performance" categories.

In addition to immunity and emission requirements, hearing aid response performance, as measured by gain, can be adversely affected by WD RF interference. The criterion established Clause 7 sets the requirement for achieving these levels and gain requirements.

The values in Table 1 are built on a set of premises, which are documented in items a) through d).

- a) First, 80 dB(SPL) is assumed as the level of the intended audio input signal.
- b) Secondly, the values given are for an equivalent CW signal. Thus, for hearing aid immunity testing, a CW signal is used to establish a field at the specified RF power level. Then the signal is modulated with 1 kHz, 80% AM modulation for the test. Thus, the peak field strength for the test is higher than the CW level by the increase created by the modulation. In a reciprocal fashion, the peak field emissions from the WD are measured. These are then adjusted by the computed AWF, which reflects the interference potential of the modulation method used.
- c) Finally, the hearing aid gain deviation is a measurement of the gain response change of the hearing aid when exposed to the E- and H-fields created by the dipole.
- d) The category levels represent available volume control adjustment availability. For instance, if the volume control requires 4 dB to 6 dB of adjustment to use the WD, it is considered within the residual reserve gain of the hearing aid but may become a problem during normal use and therefore is considered usable but not acceptable for regular use.

Where a value is contained in two categories, the stricter limit applies.

Category		Telephone RF parameters < 960 MHz			
Near field	AWF	E-field emissions		H-field emissions	
Catagory M1/T1	0	631.0 to 1122.0	V/m	1.91 to 3.39	A/m
Category M1/T1	-5	473.2 to 841.4	V/m	1.43 to 2.54	A/m
Category M2/T2	0	354.8 to 631.0	V/m	1.07 to 1.91	A/m
	-5	266.1 to 473.2	V/m	0.80 to 1.43	A/m
Cotogom: M2/T2	0	199.5 to 354.8	V/m	0.60 to 1.07	A/m
Category M3/T3	-5	149.6 to 266.1	V/m	0.45 to 0.80	A/m
	0	< 199.5	V/m	< 0.60	A/m
Category M4/T4	-5	< 149.6	V/m	< 0.45	A/m

Table 1—Hearing aid and telephone near-field parameters

Category		Telephone RF parameters > 960 MHz			
Near field	AWF	E-field emissions		H-field emissions	
Cotocom: M1/T1	0	199.5 to 354.8	V/m	0.60 to 1.07	A/m
Category M1/T1	-5	149.6 to 266.1	V/m	0.45 to 0.80	A/m
Category M2/T2	0	112.2 to 199.5	V/m	0.34 to 0.60	A/m
	-5	84.1 to 149.6	V/m	0.25 to 0.45	A/m
Cotogom: M2/T2	0	63.1 to 112.2	V/m	0.19 to 0.34	A/m
Category M3/T3	-5	47.3 to 84.1	V/m	0.14 to 0.25	A/m
	0	< 63.1	V/m	< 0.19	A/m
Category M4/T4	-5	< 47.3	V/m	< 0.14	A/m

Equipment, which is categorized according to these requirements, shall be coordinated according to Table 2. It should be noted that because the common interference response of hearing aid circuitry is proportional to the square of the RF field, a 5 dB change in the RF yields a 10 dB change in the interference level.

System classification	Articulation index (AI)	Category sum sum of hearing aid category + telephone category
Usable	0.3	Hearing aid category + telephone category = 4
Normal use	0.5	Hearing aid category + telephone category = 5
Excellent performance	0.7	Hearing aid category + telephone category = ≥ 6

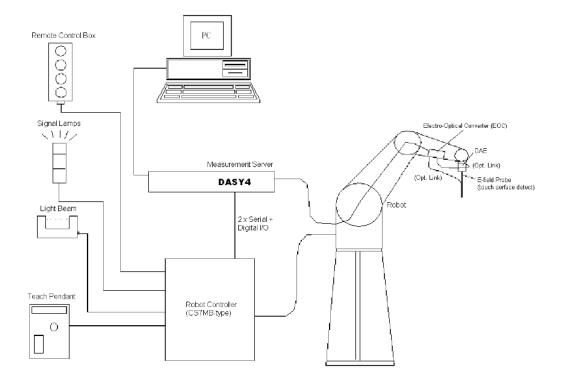
3 DESCRIPTION OF TEST SYSTEM

These measurements were performed with the automated near-field scanning system DASY4 from Schmid & Partner Engineering AG (SPEAG) which is the fourth generation of the system shown in the figure hereinafter:



The system is based on a high precision robot (working range greater than 0.9m), which positions the probes with a positional repeatability of better than ± 0.02 mm. Special E- and H-field probes have been developed for measurements close to material discontinuity, the sensors of which are directly loaded with a Schottky diode and connected via highly resistive lines to the data acquisition unit.

3.1 Measurement System Diagram



The DASY4 system for performing compliance tests consists of the following items:

- A standard high precision 6-axis robot (Stäubli RX family) with controller, teach pendant and software. An arm extension for accommodating the data acquisition electronics (DAE).
- A dosimetric probe, i.e., an isotropic E-field probe optimized and calibrated for usage in tissue simulating liquid. The probe is equipped with an optical surface detector system.
- A Data Acquisition Electronics (DAE) which performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. The unit is battery powered with standard or rechargeable batteries. The signal is optically transmitted to the EOC.
- The Electro-Optical Converter (EOC) performs the conversion between optical and electrical of the signals for the digital communication to the DAE and for the analog signal from the optical surface detection. The EOC is connected to the measurement server.
- The function of the measurement server is to perform the time critical tasks such as signal filtering, control of the robot operation and fast movement interrupts.
- A probe alignment unit which improves the (absolute) accuracy of the probe positioning.
- A computer operating Windows XP.
- DASY4 software.

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Remote control with teach pendant and additional circuitry for robot safety such as warning lamps, etc.

- The SAM twin phantom.
- The device holder for handheld mobile phones.
- Dipole for evaluating the proper functioning of the system.
- Arch Phantom.
- Validation dipole kits allowing it to validate the proper functioning of the system.

3.2 System Components

- DASY4 Measurement Server
- Data Acquisition Electronics
- Probes
- •Light Beam Unit
- Medium
- SAM Twin Phantom
- •Device Holder for SAM Twin Phantom
- •System Validation Kits
- •Robot

3.3 DASY4 Measurement Server

The DASY4 measurement server is based on a PC/104 CPU board with a 166MHz low-power Pentium, 32MB chip disk and 64MB RAM. The necessary circuits for communication with either the DAE4 (or DAE3) electronic box as well as the 16-bit AD-converter system for optical detection and digital I/O interface are contained on the DASY4 I/O-board, which is directly connected to the PC/104 bus of the CPU board.



The measurement server performs all real-time data evaluation for field measurements and surface detection, controls robot movements and handles safety operation. The PC-operating system cannot interfere with these time critical processes. All connections are supervised by a watchdog, and disconnection of any of the cables to the measurement server will automatically disarm the robot and disable all program-controlled robot movements. Furthermore, the measurement server is equipped with two expansion slots which are reserved for future applications. Please note that the expansion slots do not have a standardized pinout and therefore only the expansion cards provided by SPEAG can be inserted. Expansion cards from any other supplier could seriously damage the measurement server.

3.4 Data Acquisition Electronics

The data acquisition electronics DAE3 consists of a highly sensitive electrometer grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the measurement server is accomplished through an optical downlink for data and status information as well as an optical uplink for commands and the clock.



3.5 Light Beam Unit

The light beam switch allows automatic "tooling" of the probe. During the process, the actual position of the probe tip with respect to the robot arm is measured, as well as the probe length and the horizontal probe offset. The software then corrects all movements, so that the robot coordinates are valid for the probe tip. The repeatability of this process is better than 0.1 mm. If a position has been taught with an aligned probe, the same position will be reached with another aligned probe within 0.1 mm, even if the other probe has different dimensions. During probe rotations, the probe tip will keep its actual position.

3.6 Robot

The DASY4 system uses the high precision industrial robots RX60L, RX90 and RX90L, as well as the RX60BL and RX90BL types out of the newer series from Stäubli SA (France). The RX robot series offers many features that are important for our application:

- High precision (repeatability 0.02mm)
- High reliability (industrial design)
- Low maintenance costs (virtually maintenance-free due to direct drive gears; no belt drives)
- Jerk-free straight movements (brushless synchrony motors; no stepper motors)
- Low ELF interference (the closed metallic construction shields against motor control fields)

For the newly delivered DASY4 systems as well as for the older DASY3 systems delivered since 1999, the CS7MB robot controller version from Stäubli is used. Previously delivered systems have either a CS7 or CS7M controller; the differences to the CS7MB are mainly in the hardware, but some procedures in the robot software from Stäubli are also not completely the same. The following descriptions about robot hard- and software correspond to CS7MB controller with software version 13.1 (edit S5). The actual commands, procedures and configurations, also including details in hardware, might differ if an older robot controller is in use. In this case please also refer to the Stäubli manuals for further information.



system from collision with DUT.

3.7

	One dipole parallel, two dipoles normal to probe axis	
Construction	Built-in shielding against static charges	
	PEEK enclosure material	
Calibration	In air from 100 MHz to 3.0 GHz (absolute accuracy	E
Calibration	±6.0%, k=2)	
Frequency	40 MHz to $>$ 6 GHz (can be extended to $<$ 20 MHz)	
rrequency	Linearity: $\pm 0.2 \text{ dB}$ (100 MHz to 3 GHz)	
Directivity	\pm 0.2 dB in air (rotation around probe axis)	
Directivity	\pm 0.4 dB in air (rotation normal to probe axis)	
Dynamic Range	2 V/m to > 1000 V/m; Linearity: \pm 0.2 dB	
	Overall length: 330 mm (Tip: 16 mm)	E Filed Free space
Dimensions	Tip diameter: 8 mm (Body: 12 mm)	E-Filed Free-space
	Distance from probe tip to dipole centers: 2.5 mm	Probe
	General near-field measurements up to 6 GHz	(ER3DV6)
Application	Field component measurements	
	Fast automatic scanning in phantoms	

ER3DV6 E-Field Probe Description

The HAC measurement is conducted with the dosimetric probe ER3DV6 and H3DV6 (manufactured by SPEAG). The probe is specially designed and calibrated. This probe has a built in optical surface detection

H3DV6 H-Field Probe Description

	Three concentric loop sensors with 3.8 mm loop	
	diameters	
	Resistively loaded detector diodes for linear	
Construction	response	
	Built-in shielding against static charges	
	PEEK enclosure material (resistant to organic	
	solvents, e.g., glycolether)	
	200 MHz to 3 GHz (absolute accuracy \pm 6.0%,	
Frequency	k=2; Output linearized	
D ! (! !(· · · ·	
Directivity	\pm 0.2 dB (spherical isotropy error)	
Dynamic	10 mA/m to 2 A/m at 1 GHz	
Range	10 mA/m to 2 A/m at 1 GHZ	
E-Field	(100/(12)) CII (C 1)	
Interference	< 10% at 3 GHz (for plane wave)	
	Overall length: 330 mm (Tip: 40 mm)	H-Filed Free-space
Dimensions	Tip diameter: 6 mm (Body: 12 mm)	Probe
	Distance from probe tip to dipole centers: 3 mm	
	General magnetic near-field measurements up to 3	(H3DV6)
	GHz (in air or liquids)	
Application	Field component measurements	
••	Surface current measurements	
	Low interaction with the measured field	

E-Field and H-Field Probes

3.8 Probes Tip Description

HAC field measurements take place in the close near field gradients. Increasing the measuring distance from the surce3 will generally decrease the measured field values (in case of the validation dipole approx. 10% per mm)

Magnetic field sensors are measuring the integral of H-field across area surrounded by the loop. They are calibrated in a precise, homogeneous field. When measuring a gradient field, the result will be very close to the field in the center of the loop which is equivalent to the value of a homogeneous field equivalent to the center value. But it will be different from the field at the field at the board of the loop.

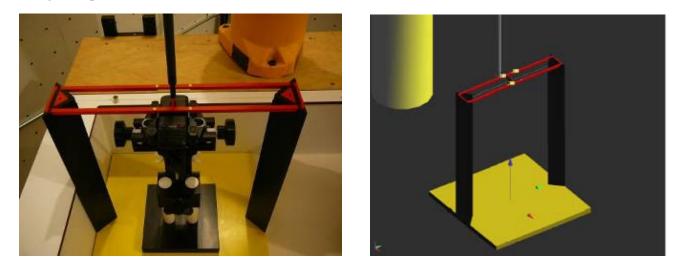
Consequently, two sensors with different loop diameters – both calibrated ideally- would give different results when measuring from the edge of probe of the probe sensor elements. The behavior for electronically small E-field sensors is equivalent.

The magnetic field loops of the H3D probes are concentric, with the center 3 mm from the tip for H3DV6.

The electric field probes have a more irregular internal geometry because it is physically not possible to have the 3 orthogonal sensors situated with the same center. The different sensor center is accounted for in HAC uncertainty budget ("sensor displacement"). Their geometric center is at 2.5 mm from the tip, and the element ends are 1.1 mm closer to the tip.

3.9 Device Holder and Phantom

The test Arch phantom should be positioned horizontally on a stable surface. Reference marking on the phantom allows the complete setup of all predefined phantom positions and measurement grids by manually teaching three points in the robot.



The DASY device holder has been made out of low-loss POM material having the following dielectric parameters: relative permittivity "=3 and loss tangent _=0.02. The amount of dielectric material has been reduced in the closest vicinity of the device, since measurements have suggested that the influence of the clamp on the test results could thus be lowered.

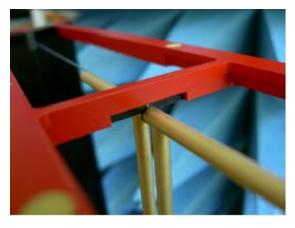
3.10 Installation of the Test Arch Phantom

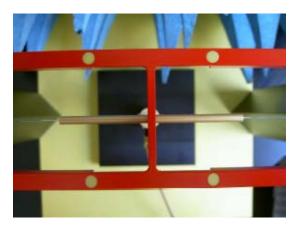
The Test Arch phantom should be positioned horizontally on a stable surface. If the cover of the Twin SAM phantom is used, side shifting after the teaching shall be avoided. In order to allow a vertical position of the probe (for both DASY4 Professional and Compact versions) the section Park position should be not higher than 15mm above the top of the upper Arch frame. For improved user friendliness a predefined configuration file of the Test Arch phantom is provided by SPEAG.

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3.11 Mounting of a Calibration Dipole

A set of three calibration dipoles (CD835, CD1880 and CD2450) is included as a part of the HAC extension. These are used for the validation of the test setup after its installation and prior to the DUT measurements. The calibration dipole is placed in the position normally occupied by the DUT. All three calibration dipoles have the same high which allows an exact fitting below the center point of the Test Arch.





Insert the base of the calibration dipole fully into the dipole holder and fix it against rotation by tightening the white screw. Connect the RF cable to the dipole and secure it before placing it below the Test Arch phantom in order to avoid mechanical stress to it. Hold the dipole on its plate at the base and press it down against the internal spring to reduce the height.

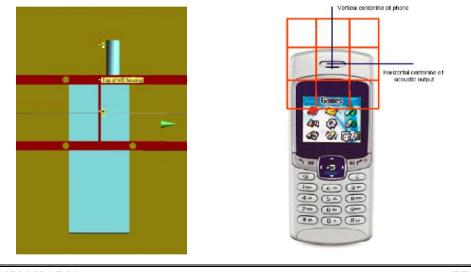
While holding the dipole down, slide the dipole on its holder centered below the arch, with the arms aligned to the dielectric wire (see graphics above). Release the dipole slowly and guide the gap between the arms into the matching center spacer below the dielectric wire.

To remove the dipole from the setup press it in the downwards direction before sliding it carefully out from below the arch.

3.12 Mounting the DUT

A DUT is mounted in the device holder equivalent as for classic dosimetric measurements The acoustic output of the DUT shall coincide with the center point of the area formed by the dielectric wire and the middle bar of the arch's top frame (see picture below).

The DUT shall be moved vertically upwards until it touches the frame. The fine adjustment is possible by sliding the complete DUT holder on the yellow base plate of the Test Arch phantom.



3.13 System Validation Kits

Each DASY system is equipped with one or more system validation kits. These units, together with the predefined measurement procedures within the DASY software, enable the user to conduct the system performance check and system validation. For that purpose a well defined SAR distribution in the flat section of the SAM twin phantom is produced.

System validation kit includes a dipole, tripod holder to fix it underneath the flat phantom and a corresponding distance holder. Dipoles are available for the variety of frequencies between 300MHz and 6 GHz (dipoles for other frequencies or media and other calibration conditions are available upon request).

The dipoles are highly symmetric and matched at the center frequency for the specified liquid and distance to the flat phantom (or flat section of the SAM-twin phantom). The accurate distance between the liquid surface and the dipole center is achieved with a distance holder that snaps on the dipole.

3.14 Probe Modulation Factor

According to ANSI C63.19: 2007, The Probe Modulation Factor (PMF) is defined as the ratio of the field reading of CW and modulated signal.

Modulation Factor (E-Field)

Frequency (MHz)	Mode	Probe Modulation Factor (PMF)
835	CW	/
	GSM	2.88
1900	CW	/
	GSM	2.88

Modulation Factor (H-Field)

Frequency (MHz)	Mode	Probe Modulation Factor (PMF)
835	CW	/
	GSM	2.88
1900	CW	/
	GSM	2.88

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4 TESTING EQUIPMENT LIST AND DETAILS

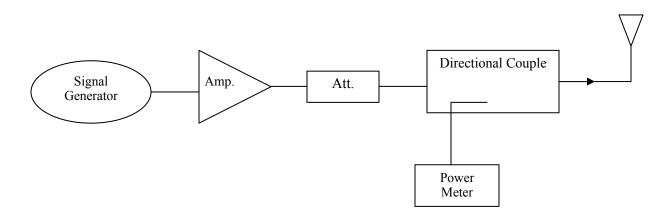
Type/Model	Cal. Due Date	Serial Number
DASY4 Professional Dosimetric System	N/A	N/A
Robot RX60L	N/A	CS7MBSP/467
Robot Controller	N/A	F01/5J72A1/A/01
Dell Computer Dimension 3000	N/A	N/A
SPEAG EDC3	N/A	N/A
SPEAG DAE3	2015-10-17	456
Probe, ER3DV6	2014-01-11	2338
Probe, H3DV6	2014-01-11	6158
SPEAG Arch Phantom	N/A	1010
SPEAG Light Alignment Sensor	N/A	278
DASY4 Measurement Server	N/A	1176
Antenna, Dipole, CD835V3	2014-01-24	1012
Antenna, Dipole, CD1880V3	2014-01-24	1009
Microwave Amp. 8349A	N/A	2644A02662
Power Meter Agilent E4419B	2014-09-01	MY4121511
Power Sensor Agilent E9301A	2014-05-09	US39211706
Analyzer Communication, CMU200	2014-06-22	103492
HP, Signal Generator, 83650B	2014-06-21	3614A00276
Agilent, Spectrum Analyzer	2014-08-09	US45303156
Antenna, Horn SAS-200/571	2014-01-18	261

5 HAC MEASUREMENT SYSTEM VERIFICATION

5.1 Purpose of System Performance Check

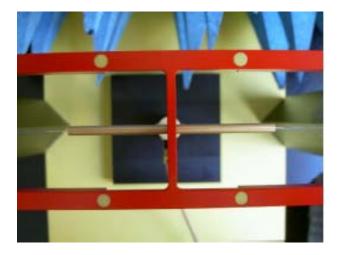
The system performance check verifies that the system operates within its specifications. System and operator errors can be detected and corrected. It is recommended that the system performance check be performed prior to any usage of the system. The system performance check use normal HAC measurements in a simplified setup with a well characterized source. This setup was selected to give a high sensitivity to all parameters that might fail or vary time. The system check does not intend to replace the calibration of the components, but indicates situations where the system uncertainty is exceeded due to drift or failure.

5.2 System Performance Check Setup



In the simplified setup for system evaluation, the EUT is replaced by a calibrated dipole and the power source is replaced by a continuous wave which comes from a signal generator at frequency 835 MHz and 1880 MHz. The calibrated dipole must be placed beneath the flat phantom section of ARC with the correct distance holder.

The output power on dipole port must be calibrated to 20 dBm (100 mw) before dipole is connected.



5.3 System Validation Results

Frequency (MHz)	Input Power (dBm)	E-Field Result (V/m)	Target E-Field (V/m)	Deviation (%)
835	20.0	179.1	171.1	4.68
1880	20.0	140.5	140.4	0

E-Field System Validation

H-Field System Validation

Frequency (MHz)	Input Power (dBm)	H-Field Result (A/m)	Target H-Field (A/m)	Deviation (%)
835	20.0	0.471	0.470	0.21
1880	20.0	0.472	0.472	0

Note: Deviation = ((E or H-Field Result)-(Target Field))/(Target Value) * 100 % Target value is provided by SPEAD in the calibration certificate.

HAC_E_Dipole_835 System Validation

DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial:

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³ Phantom section: E Dipole Section Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

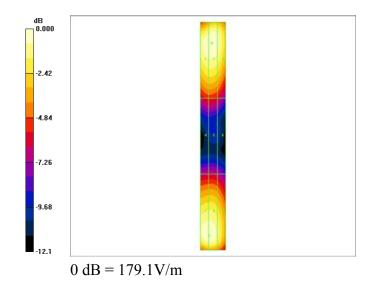
- Probe: ER3DV6 SN2338; ConvF(1, 1, 1); Calibrated: 1/11/2013
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 10/17/2013
- Phantom: HAC Test Arch; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan 10mm above CD 835 MHz/Hearing Aid Compatibility Test (41x361x1): Measurement grid: dx=5mm, dy=5mm Maximum value of peak Total field = 179.1 V/m Probe Modulation Factor = 1.00

Device Reference Point: 0.000, 0.000, 354.7 mm Reference Value = 58.0 V/m; Power Drift = -0.003 dB

Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak E-fiel	Peak E-field in V/m					
		Grid 3				
177.5 M4	179.1 M4	169.9 M4				
Grid 4	Grid 5	Grid 6				
96.7 M4	96.8 M4	90.9 M4				
Grid 7	Grid 8	Grid 9				
178.1 M4	178.2 M4	160.5 M4				



Report No.: R1310306-HAC-M

HAC_E_Dipole_1880 System Validation

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial:

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Phantom section: E Dipole Section Measurement Standard: DASY4 (High Precision Assessment)

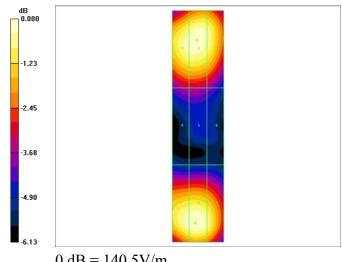
DASY4 Configuration:

- Probe: ER3DV6 SN2338; ConvF(1, 1, 1); Calibrated: 1/11/2013 •
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 10/17/2013 •
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; •
- Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan 10mm above CD 1880 MHz/Hearing Aid Compatibility Test (41x181x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 140.5 V/mProbe Modulation Factor = 1.00 Device Reference Point: 0.000, 0.000, 354.7 mm Reference Value = 81.7 V/m; Power Drift = -0.032 dBHearing Aid Near-Field Category: M2 (AWF 0 dB)

Peak E-field in V/m					
Grid 1 137.2 M2		Grid 3 1 34.7 M2			
Grid 4 95.9 M3		Grid 6 92.0 M3			
Grid 7 138.4 M2	Grid 8 140.5 M2	Grid 9 133.5 M2			



0 dB = 140.5 V/m

HAC_H_Dipole_835 System Validation

DUT: HAC-Dipole 835 MHz; Type: D835V3; Serial:

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³ Phantom section: E Dipole Section Measurement Standard: DASY4 (High Precision Assessment)

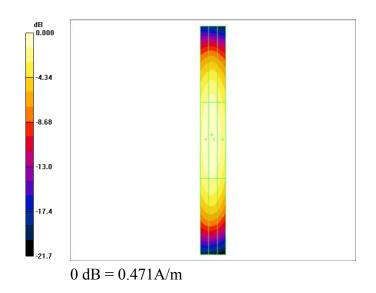
DASY4 Configuration:

- Probe: H3DV6 SN6158; ; Calibrated: 1/11/2013
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 10/17/2013
- Phantom: HAC Test Arch; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan 10mm above CD 835 MHz/Hearing Aid Compatibility Test (41x361x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.471 A/m Probe Modulation Factor = 1.00 Device Reference Point: 0.000, 0.000, 354.7 mm Reference Value = 0.467 A/m; Power Drift = -0.008 dB Hearing Aid Near-Field Category: M4 (AWF 0 dB)

Peak H-field in A/m					
		Grid 3			
0.413 M4	0.425 M4	0.391 M4			
Grid 4	Grid 5	Grid 6			
0.461 M4	0.471 M4	0.435 M4			
	0	Grid 9			
0.398 M4	0.402 M4	0.373 M4			



Report No.: R1310306-HAC-M

HAC_H_Dipole_1880 System Validation

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial:

Communication System: CW; Frequency: 1880 MHz; Duty Cycle: 1:1 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Phantom section: E Dipole Section Measurement Standard: DASY4 (High Precision Assessment)

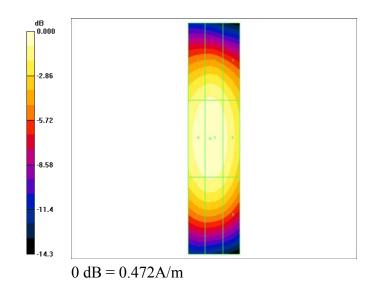
DASY4 Configuration:

- Probe: H3DV6 SN6158; ; Calibrated: 1/11/2013
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 10/17/2013
- Phantom: HAC Test Arch; Type: SD HAC P01 BA;
- Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan 10mm above CD 1880 MHz 2/Hearing Aid Compatibility Test (41x181x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.472 A/m Probe Modulation Factor = 1.00 Device Reference Point: 0.000, 0.000, 354.7 mm Reference Value = 0.470 A/m; Power Drift = 0.037 dB Hearing Aid Near-Field Category: M2 (AWF 0 dB)

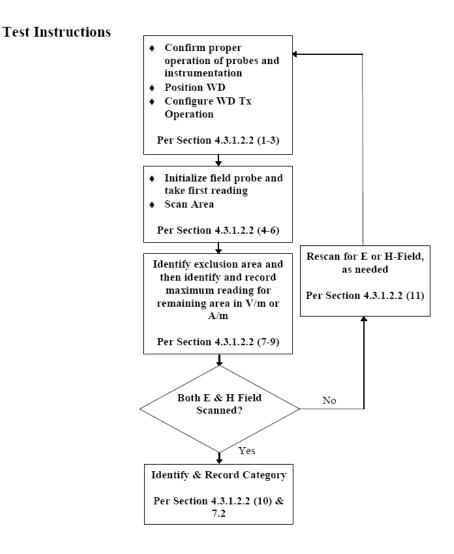
Peak H-field in A/m					
		Grid 3			
0.425 M2	0.431 M2	0.402 M2			
Grid 4	Grid 5	Grid 6			
0.466 M2	0.472 M2	0.444 M2			
Grid 7	Grid 8	Grid 9			
0.423 M2	0.429 M2	0.401 M2			



Report No.: R1310306-HAC-M

6 HAC RF EMISSIONS TEST PROCEDURE

6.1 Test Instructions



6.2 Test Setup

Figure 1 through Figure 3 illustrates the references and reference plane that shall be used in the WD emissions measurement.

- 1) The grid is 5.0 cm by 5.0 cm area that is divided into nine evenly sized blocks or sub-grids.
- 2) The grid is centered on the audio frequency output transducer of the WD (speaker or T-Coil).
- 3) The grid is in a reference plane, which is defined as the planar area that contains the highest point in the area of the phone that normally rests against the user's ear. It is parallel to the centerline of the receiver area of the phone and is defined by the points of the receiver-end of the WD handset, which, in normal handset use, rest against the ear.
- 4) The measurement plane is parallel to, and 10.0 mm in front of, the reference plane.



Figure 1. WD reference and plan for RF emission measurement

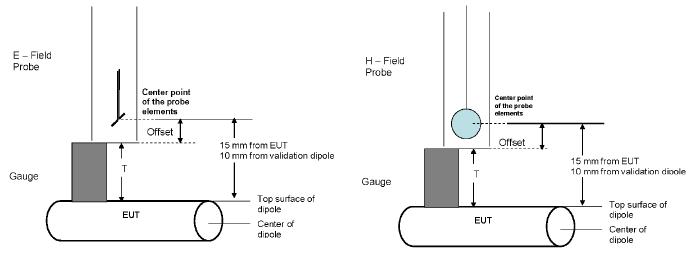


Figure 2. Gauge Block with E-field Probe

Figure 3. Gauge Block with H-field Probe

6.3 Near-Field Test Procedure

The electric field probe, and, separately, the magnetic field probe, is to be used to measure the highest field strength in the 5 cm by 5 cm scan surface. The average field strength measured over many pulse cycles may be measured, with the peak then being calculated from the measured average value and the known duty cycle of the WD.

The 5 cm by 5 cm area is divided into nine subgrids (see the diagram in Figure A.2). Three contiguous subgrids on the perimeter may be excluded from the measurement. This allows for RF "hot spots" that can easily be avoided in actual use. The highest reading found in the area defined by the middle subgrid and the remaining subgrids determines the category rating. The field probe is carefully moved through the measurement area and the maximum reading is located. In order to accurately scan the entire 5 cm by 5 cm area, the center of the probe shall be moved through this area. Accordingly the total area covered by the outside edge of the probe shall be the 5 cm by 5 cm area, increased by half (1/2) the probe diameter on all sides.

The method of displaying the data is not important as long as good measurement techniques are followed and the resultant highest .eld strength is obtained.

The distance from the WD reference plane to the nearest point on the probe element shall be 1.0 cm. The WD reference plane is a plane parallel with the front "face" of the WD and containing the highest point on its contour. The probe element is that portion of the probe that is designed to receive and sense the field being measured. The physical body of the probe housing shall not be used when setting this 1.0 cm distance as this would place the sensing elements at an indeterminate distance from the reference plane. Although it is theoretically possible to measure at almost any distance and calculate the equivalent field strengths at 1.0 cm, it is not recommended as these calculations are very difficult and prone to errors.

In the case of a field probe that may have less than three orthogonal elements, it is necessary to rotate the probe to obtain the measurement. Two methods may be used. In the preferred method, the probe shall be rotated in three dimensions for maximum alignment and the reading at maximum field alignment used. An alternative method is to rotate the probe about its geometric center so as to obtain measurements in all three mutually orthogonal orientations. The geometric center is the point that is physically located at the center of the electromagnetic sensing element of the probe. This may be determined from physical measurements or from field pattern measurements during calibration. The maximum field shall be the vector sum of all three individual mutually orthogonal measurements. Note that even when using three element probes, the probe may be rotated so as to align one element for maximum field coupling. When this is done the reading of the single, maximally aligned element is used as the field reading at that location. Readings taken in this manner are preferred over those taken with the non-aligned method because of the greater accuracy. However, when the alignment method is used, the probe shall be realigned at every measurement point.

7 MEASUREMENT UNCERTAINTY

The uncertainty budget has been determined for the DASY4 measurement system and is given in the following Table:

Wireless Communication Device Near-Field Measurement Uncertainty Estimation (According to ANSI C63.19)							
Error Description	Uncertainty Value	Prob. Dist.	Div.	(c i) E	(c i) H	Std. Unc. (E) K=2	Std. Unc. (H) K=2
Measurement System							
Probe Calibration	± 5.1 %	Ν	1	1	1	± 10.1 %	±5.1%
Axial Isotropy	± 4.7%	R	√3	1	1	±2.7%	±2.7%
Sensor Displacement	±16.5%	R	√3	1	0.145	±9.5%	±1.4%
Test Arch	±7.2%	R	$\sqrt{3}$	1	0	±4.1%	±0.0%
Linearity	±4.7%	R	$\sqrt{3}$	1	1	±2.7%	±2.7%
Scaling to Peak Envelope Power	±0.0%	R	$\sqrt{3}$	1	1	±0.0%	±0.0%
System Detection Limit	±1.0%	R	$\sqrt{3}$	1	1	±0.6%	±0.6%
Readout Electronics	±0.3%	Ν	1	1	1	±0.3%	±0.3%
Response Time	±0.8%	R	$\sqrt{3}$	1	1	±0.5%	±0.5%
Integration Time	±2.6%	R	$\sqrt{3}$	1	1	±1.5%	±1.5%
RF Ambient Conditions	±3.0%	R	$\sqrt{3}$	1	1	±1.7%	±1.7%
RF Reflections	±12.0%	R	$\sqrt{3}$	1	1	±6.9%	±6.9%
Probe Positioner	±1.2%	R	$\sqrt{3}$	1	0.67	±0.7%	±0.5%
Probe Positioning	±4.7%	R	$\sqrt{3}$	1	0.67	±2.7%	±1.8%
Extrap. and Interpolation	±1.0%	R	$\sqrt{3}$	1	1	±0.6%	±0.6%
	Te	st Sample	Related				
Device Positioning Vertical	±4.7%	R	$\sqrt{3}$	1	0.67	±2.7%	±1.8%
Device Positioning Lateral	±1.0%	R	$\sqrt{3}$	1	1	±0.6%	±0.6%
Device Holder and Phantom	±2.4%	R	$\sqrt{3}$	1	1	±1.4%	±1.4%
Power Drift	±5.0%	R	$\sqrt{3}$	1	1	±2.9%	±2.9%
	Phanto	om and Se	tup Relat	ed			
Phantom Thickness	± 2.4%	R	$\sqrt{3}$	1	0.67	±1.4%	±0.9%
Combined Std. Uncerta	unty					±15.2%	±10.8%
Expanded Std. Uncertainty	on Power					±30.4%	±21.6%
Expanded Std. Uncertainty	on Field					±15.2%	±10.8%

8 HAC MEASUREMENT SUMMARY

8.1 HAC Test Data

This page summarizes the results of the performed dosimetric evaluation. The plots with the corresponding E & H Fields distributions, which reveal information about the category of the wireless communication device with respect to the HAC test result, could be found in Appendix A.

8.2 Test Environmental Conditions

Temperature:	22 °C
Relative Humidity:	48 %
ATM Pressure:	101.4kPa

Testing was performed by Ricky Wang on 2013-11-04 in the SAR Chamber.

Frequency (MHz)	Test Type	Medium	Phantom	Notes/ Accessories	Peak Field (V/m, E-Field)	HAC Category	Plot #
824.2	E-Field	Air	Arch	none	196.3	M3	1
836.6	E-Field	Air	Arch	none	203.6	M3	2
848.8	E-Field	Air	Arch	none	219.8	M3	3
1850.2	E-Field	Air	Arch	none	68.3	M3	4
1880.0	E-Field	Air	Arch	none	73.6	M3	5
1909.8	E-Field	Air	Arch	none	64.2	M3	6

Frequency (MHz)	Test Type	Medium	Phantom	Notes/ Accessories	Peak Field (A/m, H-Field)	HAC Category	Plot #
824.2	H-Field	Air	Arch	none	0.357	M4	7
836.6	H-Field	Air	Arch	none	0.378	M4	8
848.8	H-Field	Air	Arch	none	0.404	M4	9
1850.2	H-Field	Air	Arch	none	0.229	M3	10
1880.0	H-Field	Air	Arch	none	0.246	M3	11
1909.8	H-Field	Air	Arch	none	0.238	M3	12

9 APPENDIX A – HAC MEASUREMENT RESULTS

835 E Field Testing Low CH

DUT: BinaTone Electrics; Type: GSM phone; Serial: R1310306

Communication System: GSM 850; Frequency: 824.2 MHz; Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³ Phantom section: E Dipole Section Measurement Standard: DASY4 (High Precision Assessment)

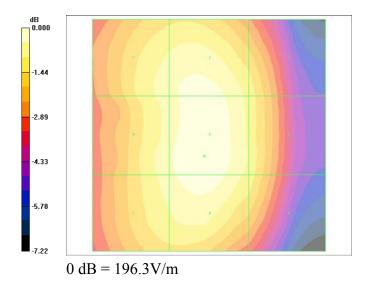
DASY4 Configuration:

- Probe: ER3DV6 SN2338; ConvF(1, 1, 1); Calibrated: 1/11/2013
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 10/17/2013
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan 10mm above 850 MHz/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 196.3 V/m Probe Modulation Factor = 2.88 Device Reference Point: 0.000, 0.000, 354.7 mm Reference Value = 71.2 V/m; Power Drift = -0.047 dB Test Arch Compensation is Applied. Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Peak E-field in V/m		
		Grid 3 172.5 M3
Grid 4	Grid 5	Grid 6 175.1 M3
	0	Grid 9 172.1 M3



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FCC HAC Report

835 E Field Testing Middle CH

DUT: BinaTone Electrics; Type: GSM phone; Serial: R1310306

Communication System: GSM 850; Frequency: 836.6 MHz; Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Phantom section: E Dipole Section Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

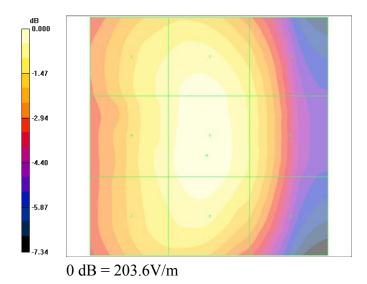
- Probe: ER3DV6 SN2338; ConvF(1, 1, 1); Calibrated: 1/11/2013
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 10/17/2013
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan 10mm above 850 MHz/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 203.6 V/m Probe Modulation Factor = 2.88 Device Reference Point: 0.000, 0.000, 354.7 mm Reference Value = 74.3 V/m; Power Drift = -0.004 dB Test Arch Compensation is Applied.

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Peak E-field in V/m			
		Grid 3 179.0 M3	
		Grid 6 181.7 M3	
	0114 0	Grid 9 178.6 M3	



Plot #2

835 E Field Testing High CH

DUT: BinaTone Electrics; Type: GSM phone; Serial: R1310306

Communication System: GSM 850; Frequency: 848.8 MHz; Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000 \text{ kg/m}^3$ Phantom section: E Dipole Section Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

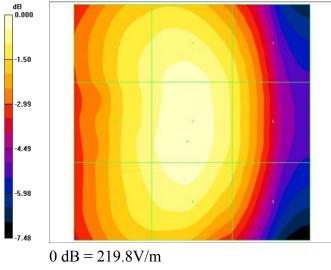
- Probe: ER3DV6 SN2338; ConvF(1, 1, 1); Calibrated: 1/11/2013
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 10/17/2013
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan 10mm above 850 MHz/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 219.8 V/m Probe Modulation Factor = 2.88 Device Reference Point: 0.000, 0.000, 354.7 mm Reference Value = 79.6 V/m; Power Drift = 0.046 dB Test Arch Compensation is Applied.

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Peak E-field in V/m		
		Grid 3 192.8 M3
Grid 4 205.8 M3		Grid 6 194.3 M3
Grid 7 203.5 M3	0	Grid 9 190.3 M3





1900 E Field Testing Low CH

DUT: BinaTone Electrics; Type: GSM phone; Serial: R1310306

Communication System: PCS 1900; Frequency: 1850.2 MHz; Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Phantom section: E Dipole Section Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

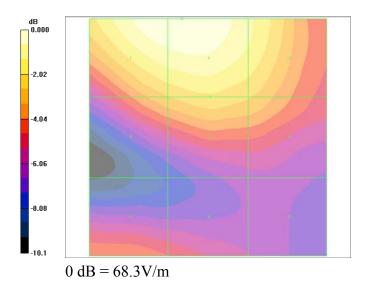
- Probe: ER3DV6 SN2338; ConvF(1, 1, 1); Calibrated: 1/11/2013
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 10/17/2013
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan 10mm above 850 MHz/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 68.3 V/mProbe Modulation Factor = 2.88Device Reference Point: 0.000, 0.000, 354.7 mm Reference Value = 18.3 V/m; Power Drift = -0.109 dBTest Arch Compensation is Applied.

Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Peak E-fie	Peak E-field in V/m			
Grid 1	Grid 2	Grid 3		
67.8 M2	68.3 M2	57.2 M3		
		Grid 6		
44.4 M3	48.8 M3	45.4 M3		
Grid 7	Grid 8	Grid 9		
34.9 M3	31.6 M3	24.3 M4		



Plot #4

1900 E Field Testing Middle CH

DUT: BinaTone Electrics; Type: GSM phone; Serial: R1310306

Communication System: PCS 1900; Frequency: 1880 MHz; Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Phantom section: E Dipole Section Measurement Standard: DASY4 (High Precision Assessment)

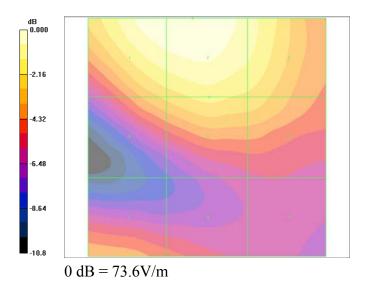
DASY4 Configuration:

- Probe: ER3DV6 SN2338; ConvF(1, 1, 1); Calibrated: 1/11/2013
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 10/17/2013
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan 10mm above 850 MHz/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 73.6 V/m Probe Modulation Factor = 2.88 Device Reference Point: 0.000, 0.000, 354.7 mm Reference Value = 20.1 V/m; Power Drift = -0.104 dB Test Arch Compensation is Applied. Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Peak E-field in V/m			
	Grid 2		
72.5 M2	73.6 M2	62.8 M3	
Grid 4	Grid 5	Grid 6	
49.0 M3	55.1 M3	51.7 M3	
Grid 7	Grid 8	Grid 9	
39.7 M3	34.7 M3	28.5 M3	



Plot #5

1900 E Field Testing High CH

DUT: BinaTone Electrics; Type: GSM phone; Serial: R1310306

Communication System: PCS 1900; Frequency: 1909.8 MHz; Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Phantom section: E Dipole Section Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ER3DV6 SN2338; ConvF(1, 1, 1); Calibrated: 1/11/2013
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 10/17/2013
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

E Scan 10mm above 850 MHz/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 64.2 V/m Probe Modulation Factor = 2.88 Device Reference Point: 0.000, 0.000, 354.7 mm Reference Value = 17.9 V/m; Power Drift = -0.160 dB Test Arch Compensation is Applied. Hearing Aid Near-Field Category: M3 (AWF -5 dB)

 Peak E-field in V/m

 Grid 1
 Grid 2
 Grid 3

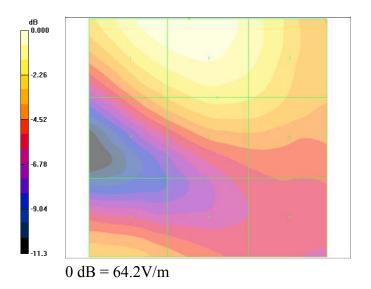
 62.8 M3
 64.2 M2
 54.8 M3

 Grid 4
 Grid 5
 Grid 6

 40.0 M3
 47.2 M3
 45.6 M3

 Grid 7
 Grid 8
 Grid 9

 37.8 M3
 32.5 M3
 26.4 M4



Plot #6

835 H Field Testing Low CH

DUT: BinaTone Electrics; Type: GSM phone; Serial: R1310306

Communication System: GSM 850; Frequency: 824.2 MHz; Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³ Phantom section: E Dipole Section Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

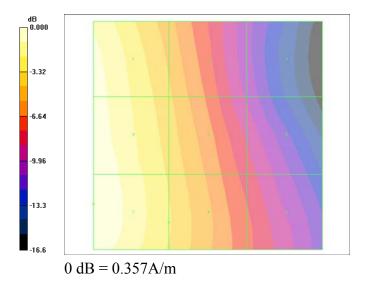
- Probe: H3DV6 SN6158; ; Calibrated: 1/11/2013
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 10/17/2013
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan 10mm above 850 MHz/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.357 A/m Probe Modulation Factor = 2.88 Device Reference Point: 0.000, 0.000, 354.7 mm Reference Value = 0.059 A/m; Power Drift = 0.234 dB Hearing Aid Near-Field Category: M4 (AWF -5 dB)

Peak H-field in A/m

Grid 1 0.333 M4	Grid 3 0.112 M4
Grid 4 0.351 M4	Grid 6 0.139 M4
	 Grid 9 0.153 M4



Plot #7

835 H Field Testing Mid CH

DUT: BinaTone Electrics; Type: GSM phone; Serial: R1310306

Communication System: GSM 850; Frequency: 836.6 MHz; Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Phantom section: E Dipole Section Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

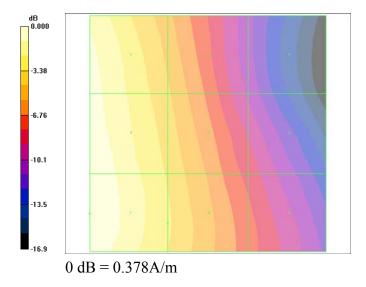
- Probe: H3DV6 SN6158; ; Calibrated: 1/11/2013
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 10/17/2013
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan 10mm above 850 MHz/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.378 A/m Probe Modulation Factor = 2.88 Device Reference Point: 0.000, 0.000, 354.7 mm Reference Value = 0.062 A/m; Power Drift = 0.265 dB Hearing Aid Near-Field Category: M4 (AWF -5 dB)

Peak H-field in A/m

	Grid 3 0.116 M4
	Grid 6 0.146 M4
 	Grid 9 0.162 M4



Plot #8

835 H Field Testing High CH

DUT: BinaTone Electrics; Type: GSM phone; Serial: R1310306

Communication System: GSM 850; Frequency: 848.8 MHz; Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³ Phantom section: E Dipole Section Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

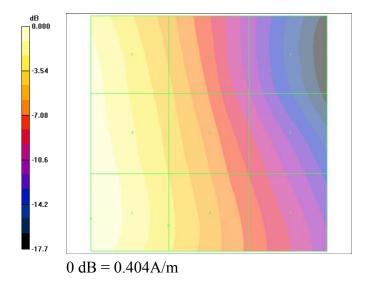
- Probe: H3DV6 SN6158; ; Calibrated: 1/11/2013
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 10/17/2013
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan 10mm above 850 MHz/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.404 A/m Probe Modulation Factor = 2.88 Device Reference Point: 0.000, 0.000, 354.7 mm Reference Value = 0.066 A/m; Power Drift = 0.218 dB Hearing Aid Near-Field Category: M4 (AWF -5 dB)

Peak H-field in A/m

	Grid 3 0.120 M4
	Grid 6 0.155 M4
 0	Grid 9 0.174 M4



Plot #9

1900 H Field Testing Low CH

DUT: BinaTone Electrics; Type: GSM phone; Serial: R1310306

Communication System: PCS 1900; Frequency: 1850.2 MHz; Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Phantom section: E Dipole Section Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

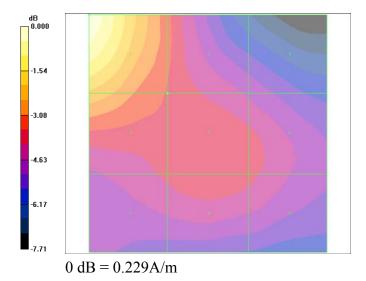
- Probe: H3DV6 SN6158; ; Calibrated: 1/11/2013
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 10/17/2013
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan 10mm above 850 MHz/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.229 A/m Probe Modulation Factor = 2.88 Device Reference Point: 0.000, 0.000, 354.7 mm Reference Value = 0.052 A/m; Power Drift = 0.076 dB Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Peak H-field in A/m

Grid 1 0.229 M3	Grid 3 0.133 M4
Grid 4 0.179 M3	 Grid 6 0.147 M3
Grid 7 0.144 M3	 Grid 9 0.145 M3



Plot #10

1900 H Field Testing Mid CH

DUT: BinaTone Electrics; Type: GSM phone; Serial: R1310306

Communication System: PCS 1900; Frequency: 1880 MHz; Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Phantom section: E Dipole Section Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

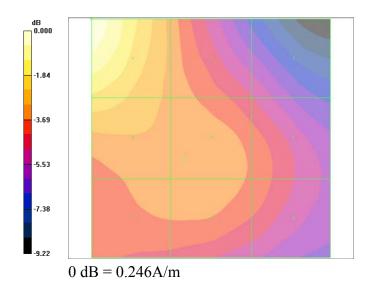
- Probe: H3DV6 SN6158; ; Calibrated: 1/11/2013
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 10/17/2013
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan 10mm above 850 MHz/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.246 A/m Probe Modulation Factor = 2.88 Device Reference Point: 0.000, 0.000, 354.7 mm Reference Value = 0.058 A/m; Power Drift = 0.066 dB Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Peak H-field in A/m

Grid 2 0.170 M3	Grid 3 0.141 M3
	Grid 6 0.160 M3
	Grid 9 0.159 M3



Plot #11

1900 E Field Testing High CH

DUT: BinaTone Electrics; Type: GSM phone; Serial: R1310306

Communication System: PCS 1900; Frequency: 1909.8 MHz; Duty Cycle: 1:8.3 Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Phantom section: E Dipole Section Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

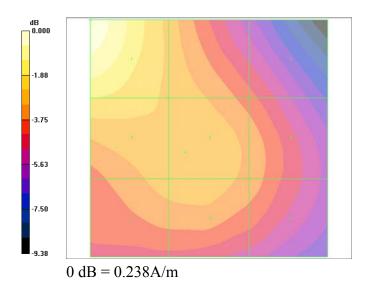
- Probe: H3DV6 SN6158; ; Calibrated: 1/11/2013
- Sensor-Surface: (Fix Surface)
- Electronics: DAE3 Sn456; Calibrated: 10/17/2013
- Phantom: HAC Test Arch; Type: SD HAC P01 BA; Serial:
- Measurement SW: DASY4, V4.7 Build 80; Postprocessing SW: SEMCAD, V1.8 Build 186

H Scan 10mm above 850 MHz/Hearing Aid Compatibility Test (101x101x1): Measurement grid: dx=5mm, dy=5mm

Maximum value of peak Total field = 0.238 A/m Probe Modulation Factor = 2.88 Device Reference Point: 0.000, 0.000, 354.7 mm Reference Value = 0.061 A/m; Power Drift = 0.043 dB Hearing Aid Near-Field Category: M3 (AWF -5 dB)

Peak H-field in A/m

	Grid 3 0.149 M3
	Grid 6 0.164 M3
 0	Grid 9 0.162 M3



Plot #12

10 APPENDIX B – PROBE CALIBRATION CERTIFICATIONS

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



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Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Client BACL

Certificate No: ER3-2338_Jan13

Object	ER3DV6 - SN:2338					
Calibration procedure(s)	QA CAL-02.v6, QA CAL-25.v4 Calibration procedure for E-field probes optimized for close near field evaluations in air					
Calibration date:	January 11, 2013					
The measurements and the unc	ertainties with confidence pr ucted in the closed laborator	anal standards, which realize the physical units obability are given on the following pages and y facility: environment temperature (22 ± 3)°C a	are part of the certificate.			
Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Calibration			
Power meter E4419B	GB41293874	29-Mar-12 (No. 217-01508)	Apr-13			
ower sensor E4412A	MY41498087	29-Mar-12 (No. 217-01508)	Apr-13			
Reference 3 dB Attenuator	SN: S5054 (3c)	27-Mar-12 (No. 217-01531)	Apr-13			
Reference 20 dB Attenuator	SN: S5086 (20b)	27-Mar-12 (No. 217-01529)	Apr-13			
Reference 30 dB Attenuator	SN: S5129 (30b)	27-Mar-12 (No. 217-01532)	Apr-13			
Reference Probe ER3DV6	SN: 2328	12-Oct-12 (No. ER3-2328_Oct12)	Oct-13			
DAE4	SN: 789	18-Sep-12 (No. DAE4-789_Sep12)	Sep-13			
	ID	Check Date (in house)	Scheduled Check			
Secondary Standards	US3642U01700	4-Aug-99 (in house check Apr-11)	In house check: Apr-13			
Contraction for an and a second second			In house check: Oct-13			
RF generator HP 8648C	US37390585	18-Oct-01 (in house check Oct-12)	In nouse check. Out-15			
RF generator HP 8648C	US37390585 Name	18-Oct-01 (in house check Oct-12) Function	Signature			
RF generator HP 8648C Network Analyzer HP 8753E	1					
Secondary Standards RF generator HP 8648C Network Analyzer HP 8753E Calibrated by: Approved by:	Name	Function				

Certificate No: ER3-2338_Jan13

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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



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- Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary:

NORMx,y,z	sensitivity in free space
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C, D	modulation dependent linearization parameters
Polarization φ	φ rotation around probe axis
Polarization &	9 rotation around an axis that is in the plane normal to probe axis (at measurement center),
	i.e., 9 = 0 is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1309-2005, "IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005
- b) CTIA Test Plan for Hearing Aid Compatibility, April 2010.

Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization ϑ = 0 for XY sensors and ϑ = 90 for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- NORM(f)x,y,z = NORMx,y,z * frequency_response (see Frequency Response Chart).
- DCPx, y, z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- Ax,y,z; Bx,y,z; Cx,y,z; Dx,y,z; VRx,y,z: A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

Certificate No: ER3-2338_Jan13

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ER3DV6 - SN:2338

January 11, 2013

Probe ER3DV6

SN:2338

Manufactured: Calibrated:

June 15, 2004 January 11, 2013

Calibrated for DASY/EASY Systems (Note: non-compatible with DASY2 system!)

Certificate No: ER3-2338_Jan13

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FCC HAC Report

ER3DV6-- SN:2338

January 11, 2013

DASY/EASY - Parameters of Probe: ER3DV6 - SN:2338

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm (µV/(V/m) ²)	1.66	1.70	1.97	± 10.1 %
DCP (mV) ⁸	98.6	98.6	98.0	

Modulation Calibration Parameters

UID	Communication System Name		A dB	B dBõV	с	D dB	VR mV	Unc ^t (k=2)
0	CW	X	0.0	0.0	1.0	0.00	166.5	±2.7 %
		Y	0.0	0.0	1.0		159.1	
		Z	0.0	0.0	1.0		157.7	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

 ⁸ Numerical linearization parameter: uncertainty not required.
 ⁶ Uncertainty is determined using the max, deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

Certificate No: ER3-2338_Jan13

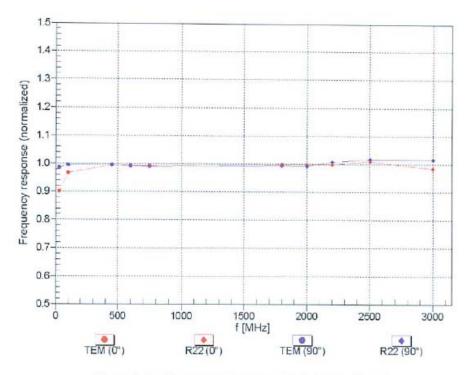
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ER3DV6- SN:2338

January 11, 2013

Frequency Response of E-Field (TEM-Cell:ifi110 EXX, Waveguide: R22)



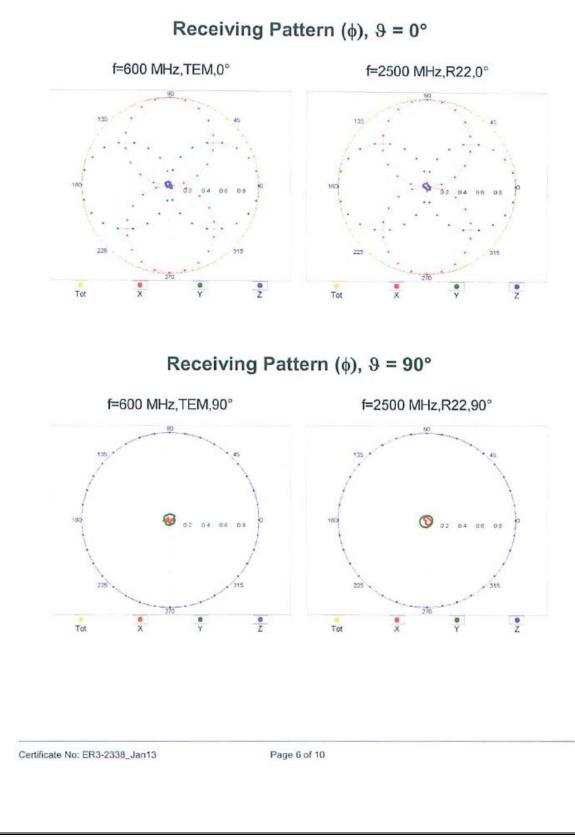


Certificate No: ER3-2338_Jan13

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ER3DV6- SN:2338

January 11, 2013



Report No.: R1310306-HAC-M

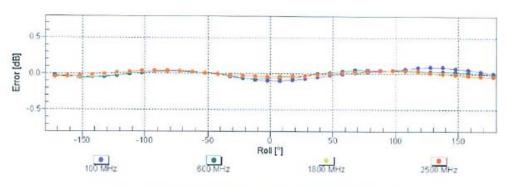
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FCC HAC Report



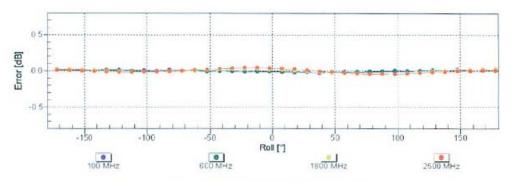
January 11, 2013





Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Receiving Pattern (ϕ), ϑ = 90°



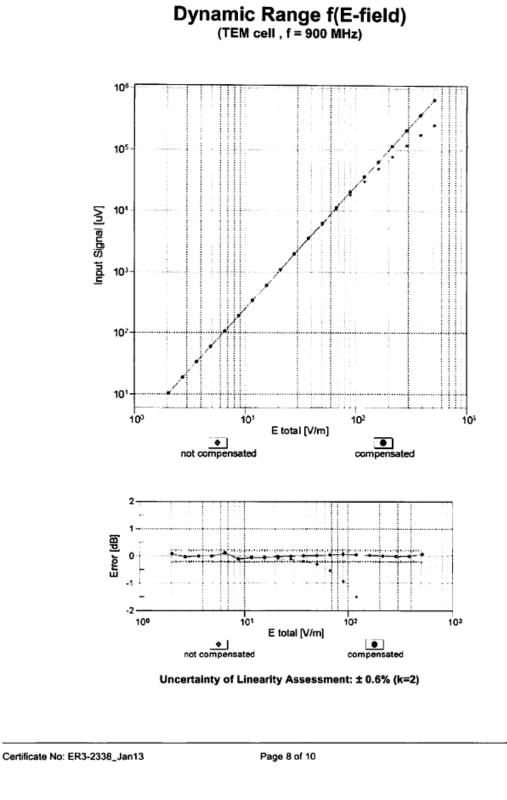
Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Certificate No: ER3-2338_Jan13

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ER3DV6- SN:2338

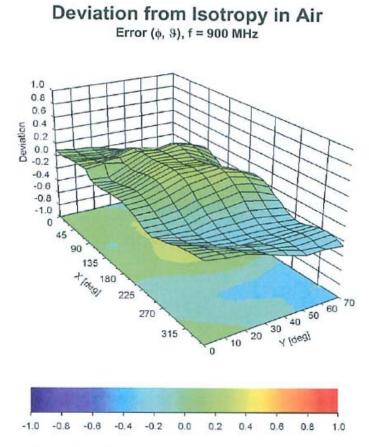
January 11, 2013



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ER3DV6- SN:2338

January 11, 2013



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

Certificate No: ER3-2338_Jan13

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FCC HAC Report

ER3DV6-- SN:2338

January 11, 2013

DASY/EASY - Parameters of Probe: ER3DV6 - SN:2338

Other Probe Parameters

Sensor Arrangement	Rectangular
Connector Angle (°)	-42.2
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	8 mm
Probe Tip to Sensor X Calibration Point	2.5 mm
Probe Tip to Sensor Y Calibration Point	2.5 mm
Probe Tip to Sensor Z Calibration Point	2.5 mm

Certificate No: ER3-2338_Jan13

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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



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Client BACL

Certificate No: H3-6158_Jan13

Accreditation No.: SCS 108

	LIODUG CHLOAS		
Dbject	H3DV6 - SN:6158	8	
Calibration procedure(s)	QA CAL-03.v6, Q Calibration procee evaluations in air	0A CAL-25.v4 dure for H-field probes optimized f	or close near field
Calibration date:	January 11, 2013		
The measurements and the unc	ertainties with confidence pr ucted in the closed laborator	onal standards, which realize the physical units obability are given on the following pages and y facility: environment temperature (22 ± 3)°C a	are part of the certificate.
Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	29-Mar-12 (No. 217-01508)	Apr-13
	MY41498087	29-Mar-12 (No. 217-01508)	Apr-13
Power sensor E4412A	Internation of the second seco		
	SN: S5054 (3c)	27-Mar-12 (No. 217-01531)	Apr-13
Reference 3 dB Attenuator			
Reference 3 dB Attenuator Reference 20 dB Attenuator	SN: S5054 (3c)	27-Mar-12 (No. 217-01531)	Apr-13
Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator	SN: S5054 (3c) SN: S5086 (20b)	27-Mar-12 (No. 217-01531) 27-Mar-12 (No. 217-01529)	Apr-13 Apr-13
Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV6	SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b)	27-Mar-12 (No. 217-01531) 27-Mar-12 (No. 217-01529) 27-Mar-12 (No. 217-01532)	Apr-13 Apr-13 Apr-13
Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV6 DAE4	SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 6182	27-Mar-12 (No. 217-01531) 27-Mar-12 (No. 217-01529) 27-Mar-12 (No. 217-01532) 12-Oct-12 (No. H3-6182_Oct12)	Apr-13 Apr-13 Apr-13 Oct-13
Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV6 DAE4 Secondary Standards	SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 6182 SN: 789	27-Mar-12 (No. 217-01531) 27-Mar-12 (No. 217-01529) 27-Mar-12 (No. 217-01532) 12-Oct-12 (No. H3-6182_Oct12) 18-Sep-12 (No. DAE4-789_Sep12)	Apr-13 Apr-13 Apr-13 Oct-13 Sep-13
Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV6 DAE4 Secondary Standards RF generator HP 8648C	SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 6182 SN: 789 ID	27-Mar-12 (No. 217-01531) 27-Mar-12 (No. 217-01529) 27-Mar-12 (No. 217-01532) 12-Oct-12 (No. H3-6182_Oct12) 18-Sep-12 (No. DAE4-789_Sep12) Check Date (in house)	Apr-13 Apr-13 Apr-13 Oct-13 Sep-13 Scheduled Check
Power sensor E4412A Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV6 DAE4 Secondary Standards RF generator HP 8648C Network Analyzer HP 8753E	SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 6182 SN: 789 ID US3642U01700	27-Mar-12 (No. 217-01531) 27-Mar-12 (No. 217-01529) 27-Mar-12 (No. 217-01529) 12-Oct-12 (No. H3-6182_Oct12) 18-Sep-12 (No. DAE4-789_Sep12) Check Date (in house) 4-Aug-99 (in house check Apr-11) 18-Oct-01 (in house check Oct-12)	Apr-13 Apr-13 Apr-13 Oct-13 Sep-13 Scheduled Check In house check: Apr-13 In house check: Oct-13
Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV6 DAE4 Secondary Standards RF generator HP 8648C Network Analyzer HP 8753E	SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 6182 SN: 789 ID US3642U01700 US37390585	27-Mar-12 (No. 217-01531) 27-Mar-12 (No. 217-01529) 27-Mar-12 (No. 217-01529) 12-Oct-12 (No. H3-6182_Oct12) 18-Sep-12 (No. DAE4-789_Sep12) Check Date (in house) 4-Aug-99 (in house check Apr-11)	Apr-13 Apr-13 Apr-13 Oct-13 Sep-13 Scheduled Check In house check: Apr-13
Reference 3 dB Attenuator Reference 20 dB Attenuator Reference 30 dB Attenuator Reference Probe H3DV6 DAE4 Secondary Standards RF generator HP 8648C	SN: S5054 (3c) SN: S5086 (20b) SN: S5129 (30b) SN: 6182 SN: 789 ID US3642U01700 US37390585 Name	27-Mar-12 (No. 217-01531) 27-Mar-12 (No. 217-01529) 27-Mar-12 (No. 217-01529) 12-Oct-12 (No. H3-6182_Oct12) 18-Sep-12 (No. DAE4-789_Sep12) Check Date (in house) 4-Aug-99 (in house check Apr-11) 18-Oct-01 (in house check Oct-12) Function	Apr-13 Apr-13 Apr-13 Oct-13 Sep-13 Scheduled Check In house check: Apr-13 In house check: Oct-13

Certificate No: H3-6158_Jan13

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Glossary

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





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 - Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Giussaiy.	
NORMx,y,z	sensitivity in free space
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C, D	modulation dependent linearization parameters
Polarization φ	φ rotation around probe axis
Polarization 8	9 rotation around an axis that is in the plane normal to probe axis (at measurement center),
	i.e., 9 = 0 is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1309-2005, " IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005.
- b) CTIA Test Plan for Hearing Aid Compatibility, April 2010.

Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization 9 = 0 for XY sensors and 9 = 90 for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- X,Y,Z(f)_a0a1a2= X,Y,Z_a0a1a2* frequency_response (see Frequency Response Chart).
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- Ax,y,z; Bx,y,z; Cx,y,z; Dx,y,z; VRx,y,z: A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- Spherical isotropy (3D deviation from isotropy): in a locally homogeneous field realized using an open waveguide setup.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the X a0a1a2 (no uncertainty required).

Certificate No: H3-6158_Jan13

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H3DV6 - SN:6158

January 11, 2013

Probe H3DV6

SN:6158

Manufactured: Calibrated:

June 22, 2004 January 11, 2013

Calibrated for DASY/EASY Systems (Note: non-compatible with DASY2 system!)

Certificate No: H3-6158_Jan13

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January 11, 2013

DASY/EASY - Parameters of Probe: H3DV6 - SN:6158

Basic Calibration Parameters

		Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm (A/m / √(mV))	a0	2.63E-003	2.60E-003	2.96E-003	± 5.1 %
Norm (A/m / √(mV))	a1	-6.19E-005	-9.93E-005	-1.34E-004	± 5.1 %
Norm (A/m / √(mV))	a2	3.15E-005	3.76E-006	3.90E-005	± 5.1 %
DCP (mV) ^B		93.7	91.9	92.2	

Modulation Calibration Parameters

UID	Communication System Name		A	В	С	D	VR	Unc ^E
			dB	dBõV		dB	mV	(k=2)
0	CW	х	0.0	0.0	1.0	0.00	137.2	±2.7 %
		Y	0.0	0.0	1.0		139.8	
		Z	0.0	0.0	1.0		135.6	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^a Numerical linearization parameter: uncertainty not required. ^c Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

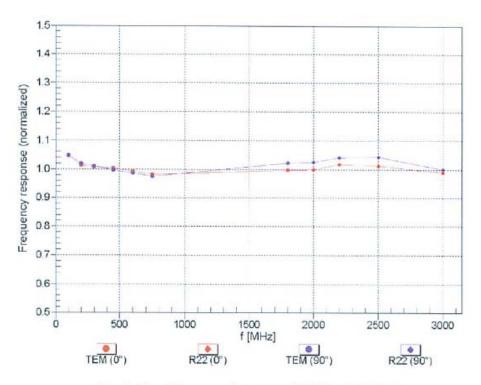
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Frequency Response of H-Field (TEM-Cell:ifi110 EXX, Waveguide: R22)

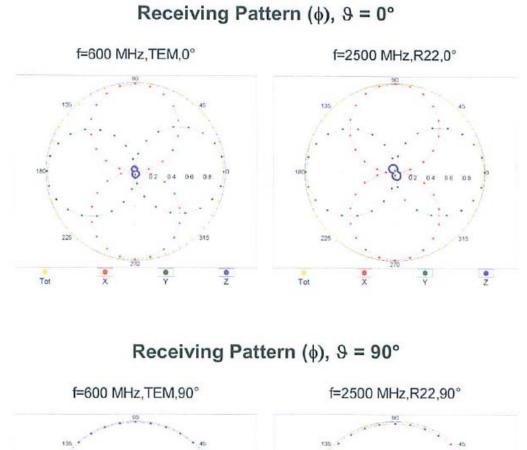


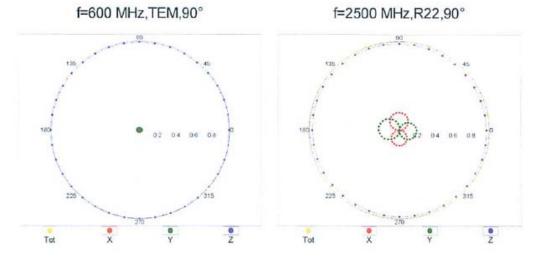
Uncertainty of Frequency Response of H-field: ± 6.3% (k=2)

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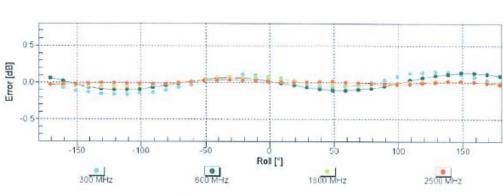




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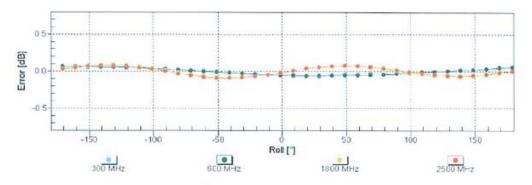
January 11, 2013



Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$

Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Receiving Pattern (ϕ), $\vartheta = 90^{\circ}$



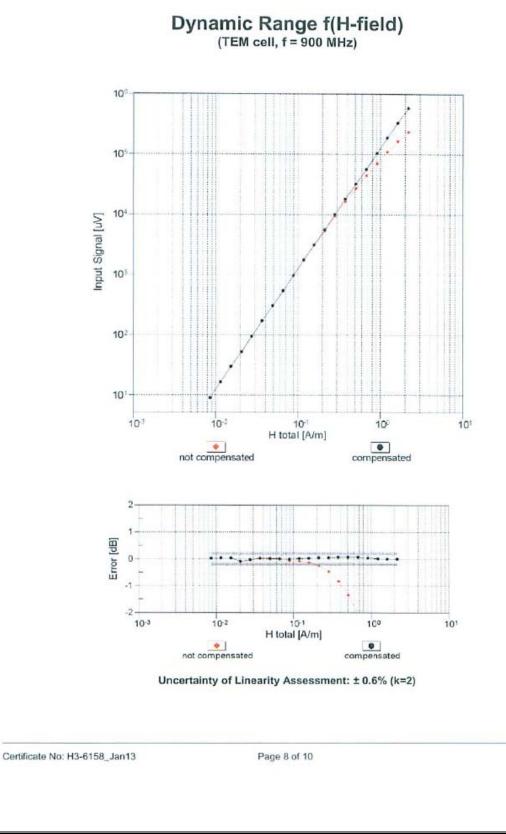
Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

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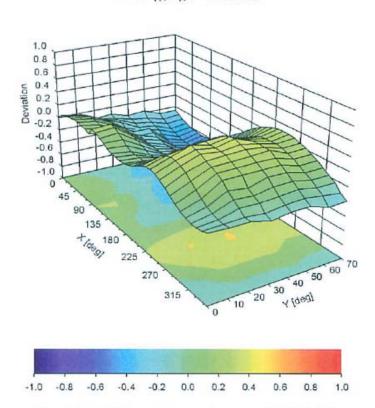
H3DV6- SN:6158

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Deviation from Isotropy in Air Error (\u00f6, \u00f3), f = 900 MHz

Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

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DASY/EASY - Parameters of Probe: H3DV6 - SN:6158

Other Probe Parameters

Sensor Arrangement	Rectangular
Connector Angle (°)	-81.1
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	20 mm
Tip Diameter	6 mm
Probe Tip to Sensor X Calibration Point	3 mm
Probe Tip to Sensor Y Calibration Point	3 mm
Probe Tip to Sensor Z Calibration Point	3 mm

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11 APPENDIX C – DIPOLE CALIBRATION CERTIFICATES

Schmid & Partner Engineering AG eughausstrasse 43, 8004 Zuri	ich, Switzerland	Iac-MRA	Service suisse d'étalonnage
ccredited by the Swiss Accredit he Swiss Accreditation Servic fulfilateral Agreement for the	ce is one of the signatori	es to the EA	No.: SCS 108
BACL	OFRICIOAT	(Control of Control of	o: CD835V3-1012_Jan12
	CD835V3 - SN:		
Calibration procedure(s)	QA CAL-20.v6 Calibration proc	edure for dipoles in air	
Calibration date:	January 24, 201	2	
The measurements and the unc	ertainties with confidence	tional standards, which realize the physical un probability are given on the following pages ar ory facility: environment temperature $(22 \pm 3)^{\circ}$	nd are part of the certificate.
The measurements and the unc All calibrations have been condi Calibration Equipment used (M2	ertainties with confidence ucted in the closed laborat &TE critical for calibration)	probability are given on the following pages ar ory facility: environment temperature $(22 \pm 3)^{\circ}$	nd are part of the certificate. C and humidity < 70%.
The measurements and the unc All calibrations have been condi Calibration Equipment used (M& Primary Standards	ertainties with confidence ucted in the closed laborat \$TE critical for calibration) ID #	probability are given on the following pages ar ory facility: environment temperature (22 ± 3) ⁴ Cal Date (Certificate No.)	nd are part of the certificate, C and humidity < 70%, Scheduled Calibration
The measurements and the unc All calibrations have been condi Calibration Equipment used (M& Primary Standards Power meter EPM-442A	ertainties with confidence ucted in the closed laborat \$TE critical for calibration) ID # GB37480704	probability are given on the following pages ar ory facility: environment temperature (22 ± 3) ⁴⁴ Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451)	nd are part of the certificate, C and humidity < 70%, Scheduled Calibration Oct-12
The measurements and the unc All calibrations have been condi Calibration Equipment used (M& Primary Standards Power meter EPM-442A Power sensor HP 8481A	ertainties with confidence ucted in the closed laborat \$TE critical for calibration) ID #	probability are given on the following pages ar ory facility: environment temperature (22 ± 3) ⁴ Cal Date (Certificate No.)	nd are part of the certificate, C and humidity < 70%, Scheduled Calibration
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The measurements and the unc All calibrations have been condi- Calibration Equipment used (M2 Primary Standards Power meter EPM-442A Power sensor HP 8481A Probe ER3DV6 Probe H3DV6 DAE4	ertainties with confidence ucted in the closed laborat STE critical for calibration) ID # GB37480704 US37292783 SN: 2336 SN: 6065 SN: 781	Cal Date (Certificate No.) 05-Oct-11 (No. 217-01451) 05-Oct-11 (No. 217-01451) 29-Dec-11 (No. 217-01451) 20-Apr-11 (No. 217-01451)	d are part of the certificate, C and humidity < 70%. Scheduled Calibration Oct-12 Oct-12 Dec-12 Dec-12 Dec-12 Dec-12 Apr-12
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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



SWISS S C C BRAS

Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

References

[1] ANSI-C63.19-2007

American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm above the top edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
 figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
 is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
 directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (in z) above the top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, 10mm above the dipole surface.
- H-field distribution: H-field is measured with an isotropic H-field probe with 100mW forward power to the
 antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The
 maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as
 calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the
 feed point.

Certificate No: CD835V3-1012_Jan12

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.8.0
Extrapolation	Advanced Extrapolation	
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	10mm	
Scan resolution	dx, dy = 5 mm	
Frequency	835MHz ± 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values

H-field 10 mm above dipole surface	condition	interpolated maximum	
Maximum measured	100 mW input power	0.470 A / m ± 8.2 % (k=2)	
E-field 10 mm above dipole surface	condition	Interpolated maximum	
Maximum measured above high end	100 mW input power	171.1 V/m	
Maximum measured above low end	100 mW input power	166.3 V / m	
Averaged maximum above arm	100 mW input power	168.7 V / m ± 12.8 % (k=2)	

Appendix

Antenna Parameters

Frequency	Return Loss	Impedance
800 MHz	14.9 dB	42.6 Ω - 15.1 jΩ
835 MHz	29.2 dB	49.6 Ω + 3.4 jΩ
900 MHz	16.7 dB	54.1 Ω - 14.9 jΩ
950 MHz	18.3 dB	43.9 Ω + 9.7 jΩ
960 MHz	14.7 dB	51.4 Ω + 19.0 jΩ

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

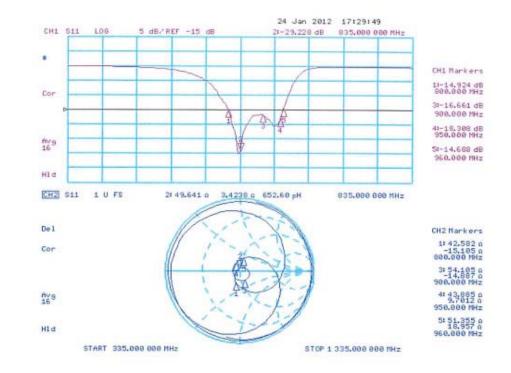
Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

Certificate No: CD835V3-1012_Jan12

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Certificate No: CD835V3-1012_Jan12

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DASY5 H-field Result

Date: 24.01.2012

Test Laboratory: SPEAG Lab2

DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1012

Communication System: CW; Frequency: 835 MHz Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

- Probe: H3DV6 SN6065; ; Calibrated: 29.12.2011
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 20.04.2011
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.0(692); SEMCAD X 14.6.4(4989)

Dipole H-Field measurement @ 835MHz/H-Scan - 835MHz d=10mm/Hearing Aid Compatibility Test (41x361x1): Measurement grid: dx=5mm, dy=5mm Device Reference Point: 0, 0, -6.3 mm Device Reference Volum Point: 0, 00, -6.3 mm

Reference Value = 0.50 V/m; Power Drift = 0.00 dB PMR not calibrated. PMF = 1.000 is applied. H-field emissions = 0.47 A/m Near-field category: M4 (AWF 0 dB)

 PMF scaled H-field

 Grid 1 M4
 Grid 2 M4
 Grid 3 M4

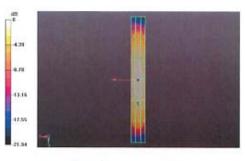
 0.39 A/m
 0.41 A/m
 0.39 A/m

 Grid 4 M4
 Grid 5 M4
 Grid 6 M4

 0.44 A/m
 0.47 A/m
 0.45 A/m

 Grid 7 M4
 Grid 8 M4
 Grid 9 M4

 0.39 A/m
 0.42 A/m
 0.40 A/m



0 dB = 0.470A/m = -6.56 dB A/m

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Certificate No: CD835V3-1012_Jan12

Report No.: R1310306-HAC-M

DASY5 E-field Result

Date: 24.01.2012

Test Laboratory: SPEAG Lab2

DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1012

Communication System: CW; Frequency: 835 MHz Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1000$ kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

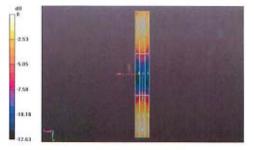
DASY52 Configuration:

- Probe: ER3DV6 SN2336; ConvF(1, 1, 1); Calibrated: 29.12.2011
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 20.04.2011
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.0(692); SEMCAD X 14.6.4(4989)

Dipole E-Field measurement @ 835MHz/E-Scan - 835MHz d=10mm/Hearing Aid Compatibility Test (41x361x1): Measurement grid: dx=5mm, dy=5mm Device Reference Point: 0, 0, -6.3 mm

Reference Value = 111.2 V/m; Power Drift = -0.02 dB PMR not calibrated. PMF = 1.000 is applied. E-field emissions = 171.1 V/m Near-field category: M4 (AWF 0 dB)





0 dB = 171.1V/m = 44.67 dB V/m

Certificate No: CD835V3-1012_Jan12

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Engineering AG Reughausstrasse 43, 8004 Zurio	ry of ch, Switzerland	Hac-MRA	 Schweizerischer Kalibrierdiens Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service
Accredited by the Swiss Accredita The Swiss Accreditation Servic Aultilateral Agreement for the r	e is one of the signatori	es to the EA	ation No.: SCS 108
Client BACL		Certificat	e No: CD1880V3-1009_Jan12
CALIBRATION	CERTIFICAT	E	
Object	CD1880V3 - SN	I: 1009	
Calibration procedure(s)	QA CAL-20.v6 Calibration proc	edure for dipoles in air	
Calibration date:	January 24, 201	2	
The measurements and the unco	ertainties with confidence	tional standards, which realize the physica probability are given on the following page ory facility: environment temperature (22 ±	es and are part of the certificate.
The measurements and the unco	ertainties with confidence	probability are given on the following page	es and are part of the certificate.
The measurements and the unco All calibrations have been condu Calibration Equipment used (M8 Primary Standards	ertainties with confidence ucted in the closed laborate TE critical for calibration)	probability are given on the following page ory facility: environment temperature (22 ± Cal Date (Certificate No.)	es and are part of the certificate. 3)°C and humidity < 70%. Scheduled Calibration
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Schweizerischer Kallbrierdienst

Service suisse d'étalonnaoi

Servizio svizzero di taratura

Swiss Calibration Service

Accreditation No.: SCS 108

Calibration Laboratory of Schmid & Partner

Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

References

[1] ANSI-C63.19-2007

American National Standard for Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

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Methods Applied and Interpretation of Parameters:

- Coordinate System: y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 10 mm above the top edge of the dipole arms.
- Measurement Conditions: Further details are available from the hardcopies at the end of the certificate. All
 figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector
 is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a
 directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- Antenna Positioning: The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections. It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- Feed Point Impedance and Return Loss: These parameters are measured using a HP 8753E Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- E-field distribution: E field is measured in the x-y-plane with an isotropic ER3D-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 10 mm (in z) above the top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, 10mm above the dipole surface.
- H-field distribution: H-field is measured with an isotropic H-field probe with 100mW forward power to the
 antenna feed point, in the x-y-plane. The scan area and sensor distance is equivalent to the E-field scan. The
 maximum of the field is available at the center (subgrid 5) above the feed point. The H-field value stated as
 calibration value represents the maximum of the interpolated H-field, 10mm above the dipole surface at the
 feed point.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.8.0
Extrapolation	Advanced Extrapolation	
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	10mm	
Scan resolution	dx, dy = 5 mm	
Frequency	1880MHz ± 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values

H-field 10 mm above dipole surface	condition	interpolated maximum	
Maximum measured	100 mW input power	0.472 A / m ± 8.2 % (k=2)	
E-field 10 mm above dipole surface	condition	Interpolated maximum	
Maximum measured above high end	100 mW input power	140.4 V / m	
Maximum measured above low end	100 mW input power	138.1 V / m	
Averaged maximum above arm	100 mW input power	139.3 V / m ± 12.8 % (k=2)	

Appendix

Antenna Parameters

Frequency	Return Loss	Impedance
1730 MHz	28.2 dB	51.6 Ω + 3.6 jΩ
1880 MHz	21.2 dB	51.5 Ω + 8.7 jΩ
1900 MHz	21.8 dB	54.0 Ω + 7.4 jΩ
1950 MHz	26.9 dB	54.4 Ω + 1.7 jΩ
2000 MHz	22.9 dB	44.3 Ω + 3.7 jΩ

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.

The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.

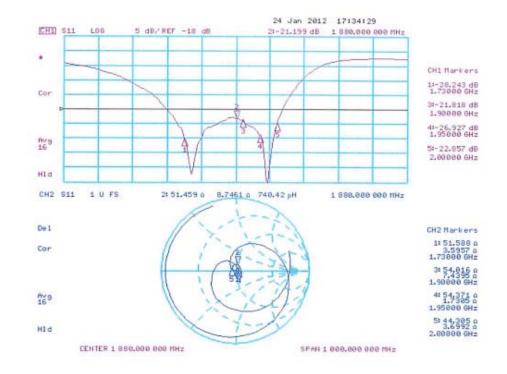
Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

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Certificate No: CD1880V3-1009_Jan12

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DASY5 H-field Result

Date: 24.01.2012

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1009

Communication System: CW; Frequency: 1880 MHz Medium parameters used: $\sigma = 0$ mho/m, $\varepsilon_r = 1$; $\rho = 1$ kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

- Probe: H3DV6 SN6065; ; Calibrated: 29.12.2011
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 20.04.2011
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.0(692); SEMCAD X 14.6.4(4989)

Dipole H-Field measurement @ 1880MHz/H-Scan - 1880MHz d=10mm/Hearing Aid Compatibility Test (41x181x1); Measurement grid: dx=5mm, dy=5mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 0.50 V/m; Power Drift = -0.01 dB

Reference Value = 0.50 V/m; Power Drift = -0.01 dB PMR not calibrated. PMF = 1.000 is applied. H-field emissions = 0.47 A/m Near-field category: M2 (AWF 0 dB)

 PMF scaled H-field

 Grid 1 M2
 Grid 2 M2
 Grid 3 M2

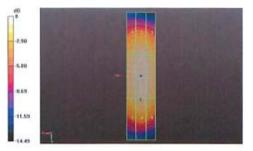
 0.41 A/m
 0.43 A/m
 0.41 A/m

 Grid 4 M2
 Grid 5 M2
 Grid 6 M2

 0.45 A/m
 0.47 A/m
 0.45 A/m

 Grid 7 M2
 Grid 8 M2
 Grid 9 M2

 0.41 A/m
 0.43 A/m
 0.42 A/m



0 dB = 0.470A/m = -6.56 dB A/m

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Certificate No: CD1880V3-1009_Jan12

Report No.: R1310306-HAC-M

DASY5 E-field Result

Date: 24.01.2012

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1009

Communication System: CW; Frequency: 1880 MHz Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1000$ kg/m³ Phantom section: RF Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY52 Configuration:

- Probe: ER3DV6 SN2336; ConvF(1, 1, 1); Calibrated: 29.12.2011
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 20.04.2011
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.8.0(692); SEMCAD X 14.6.4(4989)

Dipole E-Field measurement @ 1880MHz/E-Scan - 1880MHz d=10mm/Hearing Aid Compatibility Test (41x181x1): Measurement grid: dx=5mm, dy=5mm Device Reference Point: 0, 0, -6.3 mm Reference Value = 157.7 V/m; Power Drift = -0.00 dB

PMR not calibrated. PMF = 1.000 is applied. E-field emissions = 140.4 V/m Near-field category: M2 (AWF 0 dB)

Grid 1 MZ	Grid 2 M2	Grid 3 MZ
134.0 V/m	138.1 V/m	133.9 V/m
Grid 4 M3	Grid 5 M3	Grid 6 M3
90.05 V/m	92.10 V/m	88.07 V/m
Grid 7 M2	Grid 8 M2	Grid 9 M2
132.5 V/m	140.4 V/m	137.9 V/m



0 dB = 140.4V/m = 42.95 dB V/m

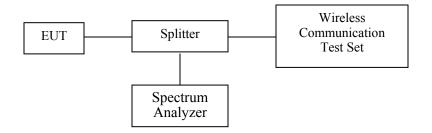
Certificate No: CD1880V3-1009_Jan12

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12 APPENDIX D – OUTPUT POWER MEASUREMENT

12.1 Test Block Diagram and Procedure

The RF output of the transmitter was connected to the input of the spectrum analyzer through sufficient attenuation.



12.2 Test Equipment List and Details

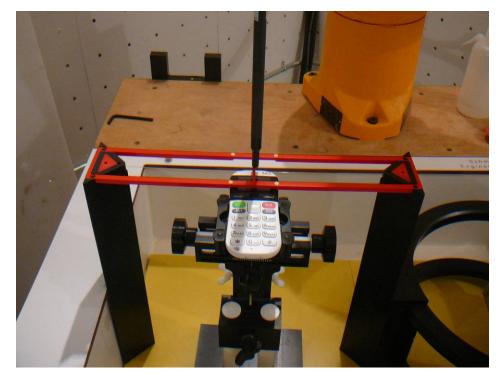
Manufacturer	Description	Model No.	Serial No.	Calibration Due Date
Rohde & Schwarz	Analyzer Communication	CMU200	103492	2014-06-22
Agilent	Spectrum Analyzer	E4440A	US45303156	2014-08-09

12.3 Test Results

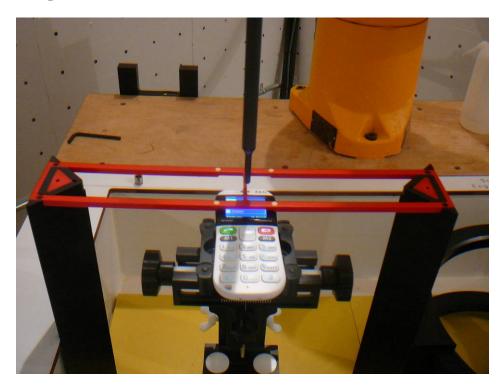
Band	Frequency (MHz)	GSM Conducted Output Power (dBm)
GSM850	824.2	32.0
	836.6	31.85
	848.8	31.98
PCS1900	1850.2	28.35
	1880.0	28.55
	1909.8	28.48

13 APPENDIX F – TEST SETUP PHOTOS

13.1 E-Field Setup View



13.2 H-Field Setup View

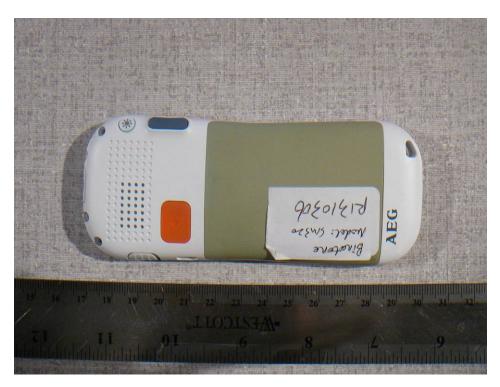


14 APPENDIX G – EUT PHOTOGRAPHS

14.1 EUT – Front View



14.2 EUT – Bottom View



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14.3 EUT – Battery Compartment View



15 APPENDIX H - REFERENCES

[1] ANSI C63.19: 2007. Americation National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids

[2] CFR47, Part 20.19, Federal Communications Commission (FCC), Hearing Aid-Compatible Mobile Handsets

[3] FCC 08-68 A1, A2, A3, A4, A5, WT Docket 07-250, February 28, 2008.

[4] FCC OET KDB 285076, Equipment Authorization Guidance for Hearing Aid Compability.

--- END OF REPORT ----